Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/500,860	SHIMIZU ET AL.	
Examiner	Art Unit	
Hae M. Hyeon	2839	

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SEARCHED					
Class	Subclass	Date	Examiner		
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439	74				
439	736				
29	876				
29	883	1/	V		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Plus Search Done	1/05	hanh		
29/837 & 842 Cursory				
Text Search Done				
Consulted with Exmr Arbes in class 29	V	V		